# NVMYS003N08LH

# Product Preview <u>MOSFET</u> - Power, Single N-Channel 80 V, 3.5 mΩ, 128 A

# Features

- Small Footprint (5x6 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- LFPAK4 Package, Industry Standard
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

# MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	80	V
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V
Continuous Drain	Steady State	$T_{C} = 25^{\circ}C$	۱ <sub>D</sub>	128	А
Current R <sub>θJC</sub> (Notes 1, 3)	State	T <sub>C</sub> = 100°C		90	
Power Dissipation		$T_{C} = 25^{\circ}C$	PD	137	W
R <sub>θJC</sub> (Note 1)		$T_{C} = 100^{\circ}C$		68	
Continuous Drain Current R <sub>0.IA</sub>	Steady State	$T_A = 25^{\circ}C$	Ι <sub>D</sub>	22	А
(Notes 1, 2, 3)	Sidle	T <sub>A</sub> = 100°C		15	
Power Dissipation		$T_A = 25^{\circ}C$	PD	3.9	W
R <sub>θJA</sub> (Notes 1, 2)		$T_A = 100^{\circ}C$		2.0	
Pulsed Drain Current	$T_A = 25^{\circ}C$ , $t_p = 10 \ \mu s$		I <sub>DM</sub>	900	А
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	–55 to +175	°C
Source Current (Body Diode)			I <sub>S</sub>	114	А
Single Pulse Drain-to-Source Avalanche Energy ( $I_{L(pk)} = 9 A$ )			E <sub>AS</sub>	TBD	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

# THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	1.1	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	38	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.

3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

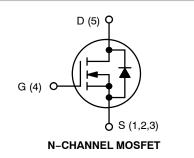
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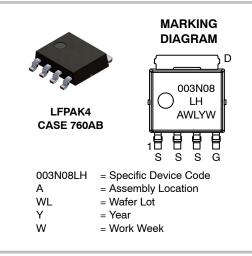


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V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
80 V	$3.5~\mathrm{m}\Omega$ @ 10 V	128 A
	4.4 mΩ @ 4.5 V	120 A





# **ORDERING INFORMATION**

See detailed ordering, marking and shipping information in the package dimensions section on page 2 of this data sheet.

# NVMYS003N08LH

# ELECTRICAL CHARACTERISTICS (T<sub>.1</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS						-	
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		80			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>				20		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V,$ $T_{J} = 25^{\circ}C$				10	μΑ
			T <sub>J</sub> = 125°C			250	1
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 20 V				100	nA
ON CHARACTERISTICS (Note 4)						-	
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 183 μA		1.2		2.0	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				TBD		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 50 A		2.9	3.5	mΩ
		$V_{GS} = 4.5 V$ $I_D = 50 A$			3.5	4.4	1
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> =15 V, I <sub>D</sub> = 50 A			TBD		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE						
Input Capacitance	C <sub>ISS</sub>	$V_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}, V_{DS} = 40 \text{ V}$ $V_{GS} = 10 \text{ V}, V_{DS} = 40 \text{ V}; \text{ I}_{D} = 50 \text{ A}$			TBD		pF
Output Capacitance	C <sub>OSS</sub>				TBD		
Reverse Transfer Capacitance	C <sub>RSS</sub>				TBD		
Total Gate Charge	Q <sub>G(TOT)</sub>				TBD		nC
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 40 V; I <sub>D</sub> = 50 A			TBD		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				TBD		-
Gate-to-Source Charge	Q <sub>GS</sub>				TBD		
Gate-to-Drain Charge	Q <sub>GD</sub>				TBD		
Plateau Voltage	V <sub>GP</sub>				TBD		V
SWITCHING CHARACTERISTICS (Note 5							
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 4.5 V, $V_{DS}$ = 64 V, I <sub>D</sub> = 50 A, R <sub>G</sub> = 2.5 Ω			TBD		ns
Rise Time	t <sub>r</sub>				TBD		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				TBD		
Fall Time	t <sub>f</sub>				TBD		1
DRAIN-SOURCE DIODE CHARACTERIS	TICS					•	
Forward Diode Voltage	$V_{SD}$ $V_{GS} = 0 V$ , $T_J = 25^{\circ}$		$T_J = 25^{\circ}C$		TBD	1.2	V
			T <sub>J</sub> = 125°C		TBD		1
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dls/dt = 100 A/μs, I <sub>S</sub> = 50 A			TBD		ns
Charge Time	ta				TBD		1
Discharge Time	t <sub>b</sub>				TBD		1
Reverse Recovery Charge	Q <sub>RR</sub>				TBD		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

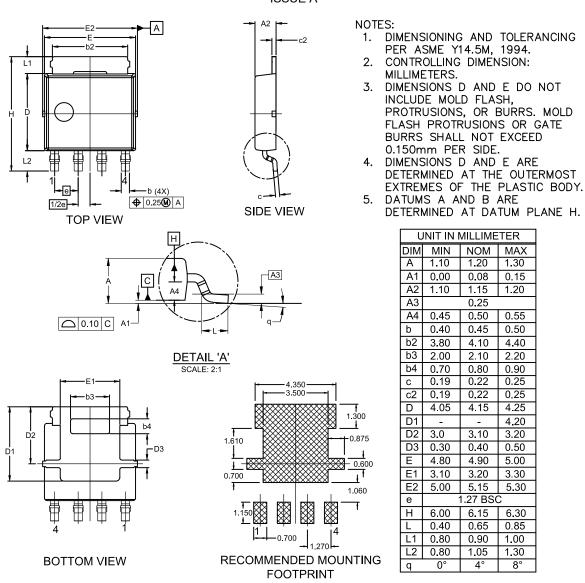
### **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NVMYS003N08LHTWG	003N08LH	LFPAK4 (Pb–Free)	3000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

### PACKAGE DIMENSIONS

LFPAK4 5x6 CASE 760AB ISSUE A



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